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Testing: Academic and Industrial Conference Practice and Research Techniques
(TAIC PART 2007)

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·Table of Contents·

■■

Testing: Academic and Industrial Conference Practice and Research Techniques
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■■

TAIC PART 2007

Paper Session 1 - Automatic Test Case Generation

Paper Session 2 - Techniques, Methods and Tools

Paper Session 3 - Model-Based Testing

Paper Session 4 - PhD Papers

Paper Session 5 - Fault Localisation and Prediction

Paper Session 6 - Constraint-Based Testing and Constraint Solving

Posters

·Table of Contents·

MUTATION 2007

MUTATION 2007

Paper Session 1 – Model-Based Mutation

Paper Session 2 – Mutation Analysis Tools

Paper Session 3 – Experimentation with Mutation

Paper Session 4 – Mutation for Security Testing